

Vikram S Kumar

List of Publications by Year in descending order

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papers

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201575

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times ranked

3153
citing authors

#	ARTICLE	IF	CITATIONS
1	A Comprehensive Review on Recent Developments in Ohmic and Schottky Contacts on Ga ₂ O ₃ for Device Applications. ACS Applied Electronic Materials, 2022, 4, 2589-2628.	2.0	32
2	Non Destructive Evaluation of AlGaIn/GaN HEMT structure by cathodoluminescence spectroscopy. Journal of Luminescence, 2021, 232, 117834.	1.5	3
3	Localized probiotic-guided pocket recolonization in the treatment of chronic periodontitis: a randomized controlled clinical trial. Journal of Periodontal and Implant Science, 2021, 51, 199.	0.9	7
4	Tuberculosis treatment spills the beans on Wilson's disease and more. Medical Journal Armed Forces India, 2021, , .	0.3	0
5	Two-dimensional analytical modelling of drain current collapse in AlGaIn/GaN HEMTs using multi-phonon ionisation by an electric field. Semiconductor Science and Technology, 2020, 35, 085035.	1.0	2
6	Growth, properties, and applications of $\text{In}_2\text{-Ga}_2\text{O}_3$ nanostructures. , 2019, , 91-115.		4
7	Carbon Nanowalls: A Potential 2-Dimensional Material for Field Emission and Energy-Related Applications. Advanced Structured Materials, 2018, , 27-71.	0.3	3
8	Temperature Dependent Electrical Characteristics of Nanostructured WO ₃ Based Ambipolar Bottom Gate FET. IEEE Nanotechnology Magazine, 2018, 17, 1288-1294.	1.1	2
9	Diameter Tuning of In_2O_3 -Ga ₂ O ₃ Nanowires Using Chemical Vapor Deposition Technique. Nanoscale Research Letters, 2017, 12, 184.	3.1	30
10	Study of GaN nanowires converted from $\text{In}_2\text{-Ga}_2\text{O}_3$ and photoconduction in a single nanowire. Semiconductor Science and Technology, 2017, 32, 085012.	1.0	13
11	Highly dispersible and uniform size Cu ₂ ZnSnS ₄ nanoparticles for photocatalytic application. Advanced Powder Technology, 2017, 28, 2402-2409.	2.0	25
12	Temperature dependent growth of GaN nanowires using CVD technique. AIP Conference Proceedings, 2016, , .	0.3	1
13	Synthesis of Cu ₂ ZnSnS ₄ nanoparticles by solvothermal route. AIP Conference Proceedings, 2016, , .	0.3	2
14	Electrical conduction noise and its correlation with structural properties of Cu ₂ ZnSnS ₄ thin films. Materials Research Express, 2016, 3, 076404.	0.8	13
15	Barrier inhomogeneities limited current and 1/f noise transport in GaN based nanoscale Schottky barrier diodes. Scientific Reports, 2016, 6, 27553.	1.6	35
16	Aperiodic Silicon Nanowire Arrays: Fabrication, Light Trapping Properties and Solar Cell Applications. Advanced Structured Materials, 2016, , 329-363.	0.3	6
17	Enhanced Thermionic Emission and Low 1/f Noise in Exfoliated Graphene/GaN Schottky Barrier Diode. ACS Applied Materials & Interfaces, 2016, 8, 8213-8223.	4.0	60
18	Designing variable height carbon nanotube bundle for enhanced electron field emission. Physica E: Low-Dimensional Systems and Nanostructures, 2015, 69, 171-176.	1.3	7

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19	High Field Emission Current Density from Patterned Carbon Nanotube Field Emitter Arrays with Random Growth. <i>Journal of Nanoscience and Nanotechnology</i> , 2015, 15, 3846-3851.	0.9	3
20	Simulation of field emission behavior from multiple carbon nanotubes in an integrated gate triode configuration. <i>Physica E: Low-Dimensional Systems and Nanostructures</i> , 2014, 63, 268-271.	1.3	3
21	Fabrication of silicon nanowire arrays based solar cell with improved performance. <i>Solar Energy Materials and Solar Cells</i> , 2011, 95, 215-218.	3.0	165
22	Role of surface modification of colloidal CdSe quantum dots on the properties of hybrid organic-inorganic nanocomposites. <i>Colloid and Polymer Science</i> , 2010, 288, 841-849.	1.0	18
23	Excellent antireflection properties of vertical silicon nanowire arrays. <i>Solar Energy Materials and Solar Cells</i> , 2010, 94, 1506-1511.	3.0	229
24	Poly(3-hexylthiophene): Functionalized single-walled carbon nanotubes: (6,6)-phenyl-C61-butyric acid methyl ester composites for photovoltaic cell at ambient condition. <i>Solar Energy Materials and Solar Cells</i> , 2010, 94, 2386-2394.	3.0	37
25	J-V characteristics of GaN containing traps at several discrete energy levels. <i>Solid-State Electronics</i> , 2010, 54, 288-293.	0.8	4
26	The origin of DC electrical conduction and dielectric relaxation in pristine and doped poly(3-hexylthiophene) films. <i>Journal of Polymer Science, Part B: Polymer Physics</i> , 2010, 48, 1047-1053.	2.4	12
27	Enhancement in hole current density on polarization in poly(3-hexylthiophene):cadmium selenide quantum dot nanocomposite thin films. <i>Applied Physics Letters</i> , 2009, 94, .	1.5	19
28	Effect of Active Layer Thickness on Open Circuit Voltage in Organic Photovoltaic Devices. <i>Japanese Journal of Applied Physics</i> , 2009, 48, 121501.	0.8	19
29	Broad spectral sensitivity and improved efficiency in CuPc/Sub-Pc organic photovoltaic devices. <i>Journal Physics D: Applied Physics</i> , 2009, 42, 015103.	1.3	46
30	Effect of illumination intensity and temperature on open circuit voltage in organic solar cells. <i>Applied Physics Letters</i> , 2009, 94, .	1.5	48
31	Effect of illumination on the space charge limited current in organic bulk heterojunction diodes. <i>Applied Physics A: Materials Science and Processing</i> , 2009, 94, 281-286.	1.1	28
32	Large-scale synthesis, characterization and photoluminescence properties of amorphous silica nanowires by thermal evaporation of silicon monoxide. <i>Physica E: Low-Dimensional Systems and Nanostructures</i> , 2009, 41, 1545-1549.	1.3	34
33	Effect of temperature on the performance of CuPc/C60 photovoltaic device. <i>Journal Physics D: Applied Physics</i> , 2009, 42, 015102.	1.3	21
34	Effect of non-zero Schottky barrier on the J-V characteristics of organic diodes. <i>European Physical Journal E</i> , 2009, 28, 361-368.	0.7	12
35	A model for the J-V characteristics of P3HT:PCBM solar cells. <i>Journal of Applied Physics</i> , 2009, 105, .	1.1	77
36	A model for the current-voltage characteristics of organic bulk heterojunction solar cells. <i>Journal Physics D: Applied Physics</i> , 2009, 42, 055102.	1.3	25

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37	Excellent Field Emission Properties of Short Conical Carbon Nanotubes Prepared by Microwave Plasma Enhanced CVD Process. <i>Nanoscale Research Letters</i> , 2008, 3, .	3.1	27
38	Effect of Substrate Morphology on Growth and Field Emission Properties of Carbon Nanotube Films. <i>Nanoscale Research Letters</i> , 2008, 3, 205-212.	3.1	16
39	Trap filled limit and high currentâ€“voltage characteristics of organic diodes with non-zero Schottky barrier. <i>Journal Physics D: Applied Physics</i> , 2008, 41, 155108.	1.3	9
40	Effect of FeCl ₃ on the stability of ï€-conjugation of electronic polymer. <i>Corrosion Science</i> , 2008, 50, 301-308.	3.0	4
41	Conduction mechanisms in poly(3-hexylthiophene) thin-film sandwiched structures. <i>Semiconductor Science and Technology</i> , 2008, 23, 035008.	1.0	13
42	Effect of CoFe magnetic nanoparticles on the hole transport in poly(2-methoxy, 5-(2-ethylhexyloxy)) Tj ETQq0 0 0 rgBT /Overlock 10 Tf 5	1.3	8
43	Effect of surface passivating ligand on structural and optoelectronic properties of polymerâ€“CdSe quantum dot composites. <i>Journal Physics D: Applied Physics</i> , 2008, 41, 235409.	1.3	44
44	Effect of CdSe quantum dots on hole transport in poly(3-hexylthiophene) thin films. <i>Applied Physics Letters</i> , 2008, 92, .	1.5	21
45	Effect of Catalyst Film Thickness on the Growth, Microstructure and Field Emission Characteristics of Carbon Nanotubes. , 2007, , .		4
46	Fabrication of WOLED by blue florescent host doped with red phosphorescent dyes. , 2007, , .		0
47	Low frequency ac conduction and dielectric relaxation in pristine poly(3-octylthiophene) films. <i>New Journal of Physics</i> , 2007, 9, 40-40.	1.2	24
48	Study of electron mobility in small molecular SAIq by transient electroluminescence method. <i>Journal Physics D: Applied Physics</i> , 2007, 40, 7313-7317.	1.3	11
49	Currentâ€“voltage characteristics of an organic diode: Revisited. <i>Synthetic Metals</i> , 2007, 157, 905-909.	2.1	14
50	Trap filled limit voltage (VTFL) and V2 law in space charge limited currents. <i>Journal of Applied Physics</i> , 2007, 102, .	1.1	83
51	Improved efficiency of Organic Light Emitting Diodes by doping of hole transport layer. , 2007, , .		0
52	Effect of thermal treatment on the performance of organic bulk-hetrojunction photovoltaic devices. , 2007, , .		0
53	A novel non-TOPO route for the synthesis of colloidal CdSe quantum dots with high luminescence and stability. , 2007, , .		1
54	Charge transport through conducting organic poly(2-methoxy-5- (2-ethylhexyloxy)-1,) Tj ETQq0 0 0 rgBT /Overlock 10 Tf 50 62 Td (4-ph	1.3	32

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55	Self-assembly of SWCNT in P3HT matrix. <i>Diamond and Related Materials</i> , 2007, 16, 446-453.	1.8	20
56	Micromorphology, photophysical and electrical properties of pristine and ferric chloride doped poly(3-hexylthiophene) films. <i>Materials Chemistry and Physics</i> , 2007, 104, 390-396.	2.0	44
57	Temperature Effect on Current-Voltage Characteristics of Molecular Organic Tris(8-hydroxyquinoline) Aluminium Complex. <i>Japanese Journal of Applied Physics</i> , 2006, 45, 7621-7624.	0.8	11
58	Enhanced field emission characteristics of nitrogen-doped carbon nanotube films grown by microwave plasma enhanced chemical vapor deposition process. <i>Thin Solid Films</i> , 2006, 515, 1851-1856.	0.8	83
59	Analysis of leakage currents in MOCVD grown GaInAsSb based photodetectors operating at 2 μm . <i>Journal of Electronic Materials</i> , 2006, 35, 1613-1617.	1.0	20
60	Characteristics of a conducting organic diode with finite (nonzero) Schottky barrier. <i>Journal of Applied Physics</i> , 2006, 100, 114506.	1.1	25
61	Structure-conductivity correlation in ferric chloride-doped poly(3-hexylthiophene). <i>New Journal of Physics</i> , 2006, 8, 112-112.	1.2	56
62	dc electrical conduction and morphology of poly(3-octylthiophene) films. <i>Journal Physics D: Applied Physics</i> , 2006, 39, 196-202.	1.3	19
63	Mechanism of charge transport in poly(3-octylthiophene). <i>Journal of Applied Physics</i> , 2006, 100, 016106.	1.1	17
64	The origin of low-frequency negative transconductance dispersion in a pseudomorphic HEMT. <i>Semiconductor Science and Technology</i> , 2005, 20, 783-787.	1.0	5
65	Improvement in crystalline quality of Cd _{1-x} Zn _x Te(x=4%) crystals grown in graphite crucible. <i>Journal of Crystal Growth</i> , 2004, 260, 148-158.	0.7	21
66	Trap density in conducting organic semiconductors determined from temperature dependence of $J\sim V$ characteristics. <i>Journal of Applied Physics</i> , 2003, 94, 1283-1285.	1.1	143
67	Effect of ambient on the thermal parameters of a micromachined bolometer. <i>Applied Physics Letters</i> , 2003, 82, 2721-2723.	1.5	2
68	Effect of field dependent trap occupancy on organic thin film transistor characteristics. <i>Journal of Applied Physics</i> , 2003, 94, 5302.	1.1	12
69	Carrier transport in conducting polymers with field dependent trap occupancy. <i>Journal of Applied Physics</i> , 2002, 92, 7325-7329.	1.1	25
70	Temperature dependence of carrier transport in conducting polymers: Similarity to amorphous inorganic semiconductors. <i>Journal of Applied Physics</i> , 2002, 92, 3835-3838.	1.1	62
71	Excellent rectifying characteristics in Au/n-CdTe diodes upon exposure to rf nitrogen plasma. <i>Semiconductor Science and Technology</i> , 1999, 14, 909-914.	1.0	3
72	XRT mapping of strain induced by 200 MeV Ag ¹⁴⁺ ions in Si(001). <i>Materials Chemistry and Physics</i> , 1998, 54, 293-295.	2.0	1

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73	Evidence for two Si-related DX like centers in Al _x Ga _{1-x} As and GaAs. Solid State Communications, 1998, 106, 163-168.	0.9	1
74	CO-implantation of Si and Be in Si GaAs for improved device performance. Solid-State Electronics, 1998, 42, 1905-1910.	0.8	1
75	Conductance deep-level transient spectroscopic study of anomalous hole trap in GaAs MESFETs. Semiconductor Science and Technology, 1998, 13, 1094-1099.	1.0	7
76	Inverted order of acceptor and donor levels of the Si-related DX center in Al _x Ga _{1-x} As. Physical Review B, 1997, 55, 4042-4045.	1.1	6
77	The physics and technology of gallium antimonide: An emerging optoelectronic material. Journal of Applied Physics, 1997, 81, 5821-5870.	1.1	631
78	Confirmation of metastable neutral DX ⁰ state of Si-related DX center in Al _x Ga _{1-x} As by transient photoconductivity. Solid State Communications, 1997, 104, 781-785.	0.9	7
79	Carrier compensation and scattering mechanisms in p-GaSb. Journal of Applied Physics, 1996, 80, 2847-2853.	1.1	32
80	Deep level transient spectroscopic study of DX center in heavily doped ion-implanted GaAs. Solid State Communications, 1996, 98, 195-199.	0.9	2
81	Modelling temperature distribution in cylindrical crystal growth furnaces. International Communications in Heat and Mass Transfer, 1996, 23, 377-386.	2.9	2
82	Influence of arsenic concentration on the surface morphology and photoluminescence of LPE grown with high aluminium content. Journal of Crystal Growth, 1996, 160, 177-180.	0.7	1
83	Fine structure in 1.4 eV luminescence band from plasma deposited amorphous silicon layers on silicon substrates. Applied Physics Letters, 1996, 68, 1458-1460.	1.5	4
84	Passivation of surface and bulk defects in p-GaSb by hydrogenated amorphous silicon treatment. Journal of Applied Physics, 1996, 79, 3246-3252.	1.1	12
85	Shallow donor neutralization in CdTe:In by atomic hydrogen. Applied Physics Letters, 1996, 68, 2424-2426.	1.5	21
86	Hydrogen Passivation of Shallow Dopants in InP Studied by Photoluminescence Spectroscopy. Materials Research Society Symposia Proceedings, 1995, 378, 453.	0.1	0
87	Hydrogen Passivation of Shallow Dopants in Indium Doped Bulk CdTe. Materials Research Society Symposia Proceedings, 1995, 378, 423.	0.1	2
88	Effect of Hydrogenation on the Electrical and Optical Properties of GaSb. Materials Research Society Symposia Proceedings, 1995, 396, 533.	0.1	0
89	Morphological Evolution and Properties of LPE Grown GaSb, AlGaSb and AlGaAsSb. Materials Research Society Symposia Proceedings, 1995, 399, 153.	0.1	0
90	Cathodoluminescence Spectroscopy For Evaluation Of Defect Passivation In GaSb. Materials Research Society Symposia Proceedings, 1995, 406, 537.	0.1	0

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91	Numerical analysis of melt-solid interface shapes and growth rates of gallium antimonide in a single-zone vertical Bridgman furnace. <i>Journal of Crystal Growth</i> , 1995, 154, 213-222.	0.7	11
92	Buckling patterns in diamond-like carbon films. <i>Thin Solid Films</i> , 1995, 256, 94-100.	0.8	60
93	Liquid phase epitaxial growth of pure and doped GaSb layers: morphological evolution and native defects. <i>Bulletin of Materials Science</i> , 1995, 18, 865-874.	0.8	4
94	Some recent advances in bulk growth of mercury cadmium telluride crystals. <i>Bulletin of Materials Science</i> , 1995, 18, 385-394.	0.8	0
95	Reactivation kinetics of acceptors in hydrogenated InP during unbiased annealing. <i>Physical Review B</i> , 1995, 51, 1536-1540.	1.1	7
96	Optical and electrical properties of hydrogen-passivated gallium antimonide. <i>Physical Review B</i> , 1995, 51, 2153-2158.	1.1	14
97	Effect of hydrogenation and thermal annealing on the photoluminescence of InP. <i>Journal of Applied Physics</i> , 1995, 77, 5398-5405.	1.1	8
98	Electrical characterization of surface defects in GaSb created by hydrogen plasma. <i>Applied Physics Letters</i> , 1995, 66, 1986-1988.	1.5	10
99	Effect of ruthenium passivation on the optical and electrical properties of gallium antimonide. <i>Journal of Applied Physics</i> , 1995, 77, 4825-4827.	1.1	19
100	Current transport properties of metal/hydrogenated amorphous silicon/GaSb structures. <i>Applied Physics Letters</i> , 1995, 67, 1001-1003.	1.5	8
101	Resistance switching in indium phosphide using hydrogen passivation of acceptors. <i>Applied Physics Letters</i> , 1994, 64, 2256-2257.	1.5	6
102	Donor-related deep level in bulk GaSb. <i>Applied Physics Letters</i> , 1994, 65, 1412-1414.	1.5	26
103	Sulphur passivation of gallium antimonide surfaces. <i>Applied Physics Letters</i> , 1994, 65, 1695-1697.	1.5	57
104	Growth of gallium antimonide by vertical Bridgman technique with planar crystal-melt interface. <i>Journal of Crystal Growth</i> , 1994, 141, 44-50.	0.7	45
105	Experimental determination of melt-solid interface shapes and actual growth rates of gallium antimonide grown by vertical Bridgman method. <i>Journal of Crystal Growth</i> , 1994, 141, 476-478.	0.7	8
106	Influence of deviation from stoichiometry on the photoluminescence in CdTe doped with indium. <i>Bulletin of Materials Science</i> , 1994, 17, 1057-1064.	0.8	6
107	A deep level spectroscopic technique for determining capture cross-section activation energy of Si-related DX centers in Al _x Ga _{1-x} As. <i>Journal of Applied Physics</i> , 1994, 75, 8243-8245.	1.1	5
108	Reduced phosphorus loss from InP surface during hydrogen plasma treatment. <i>Applied Physics Letters</i> , 1994, 64, 1696-1698.	1.5	16

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109	Bright red electroluminescence in diffused porous silicon-p-n junction. Bulletin of Materials Science, 1993, 16, 239-241.	0.8	5
110	Interfacial electrical properties of diamond-like carbon/gallium arsenide heterostructures. Diamond and Related Materials, 1993, 2, 1459-1463.	1.8	1
111	Reverse-bias annealing kinetics of Mg-H complexes in InP. Journal of Applied Physics, 1993, 74, 4521-4526.	1.1	17
112	Anomalous Dopant Redistribution in Nd:YAG Laser Annealed Low Energy Ion Implanted Silicon. Japanese Journal of Applied Physics, 1992, 31, 1287-1289.	0.8	7
113	Direct evidence for the negative-charge nature of the DX center in Al _x Ga _{1-x} As. Physical Review B, 1992, 46, 7533-7536.	1.1	13
114	Evidence for Metastable State of DX Center in Al _x Ga _{1-x} As. Materials Research Society Symposia Proceedings, 1992, 262, 579.	0.1	0
115	Passivation of Surface and Bulk Defects in InP. Materials Research Society Symposia Proceedings, 1992, 262, 413.	0.1	1
116	Transient photoconductivity in Si-doped Al _{0.26} Ga _{0.74} As. Solid State Communications, 1992, 83, 37-39.	0.9	6
117	High-frequency capacitance-voltage characteristics of amorphous (undoped)/crystalline silicon heterostructures. Solid-State Electronics, 1991, 34, 535-543.	0.8	4
118	Silver- and Gold-Related Deep Levels in Gallium Arsenide. Japanese Journal of Applied Physics, 1991, 30, 2815-2818.	0.8	4
119	Characterization of defects in gallium arsenide. Bulletin of Materials Science, 1990, 13, 83-88.	0.8	0
120	Interface State Density Distribution in Amorphous/Crystalline Silicon Heterostructures. Japanese Journal of Applied Physics, 1989, 28, L744-L746.	0.8	1
121	Neutralization of phosphorus in polycrystalline silicon by hydrogenation. Journal of Applied Physics, 1988, 63, 2867-2868.	1.1	3
122	Determination of activation energy for thermal regeneration of EL2 from its metastable state by thermally stimulated photocurrent measurements. Journal of Applied Physics, 1988, 64, 956-958.	1.1	20
123	System effects in double-channel gated-integrator-based deep-level transient spectroscopy. Journal of Applied Physics, 1988, 64, 6311-6314.	1.1	5
124	Electrical properties of nickel-related deep levels in silicon. Journal of Applied Physics, 1987, 61, 1449-1455.	1.1	24
125	Comment on "Interstitial hydrogen and neutralization of shallow-donor impurities in single-crystal silicon". Physical Review Letters, 1987, 59, 2115-2115.	2.9	7
126	Theoretical optimization of metal-p ⁿ silicon Schottky barrier solar cell. Pramana - Journal of Physics, 1985, 25, 587-596.	0.9	0

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127	A DLTS technique for surface state capture cross-section measurement of MOS diodes. Applications of Surface Science, 1985, 22-23, 1004-1010.	1.0	1
128	The photoionisation energy of the thermally induced $E_v+0.42$ eV level in p-silicon. Journal of Physics C: Solid State Physics, 1985, 18, 5095-5098.	1.5	3
129	Graphical method to include temperature variation of activation energy in Hall data analysis. Journal of Applied Physics, 1985, 57, 5529-5531.	1.1	0
130	Applicability of the van der Pauw's Hall measurement technique to implanted samples. Journal of Applied Physics, 1984, 55, 4450-4451.	1.1	2
131	Deep levels related to ion-implanted tellurium in silicon. Journal of Applied Physics, 1983, 54, 6417-6420.	1.1	8
132	Characteristics of Cr-SiO ₂ -nSi tunnel diodes. Solid-State Electronics, 1977, 20, 143-152.	0.8	59